



CEPC vertex Detector

Zhijun Liang



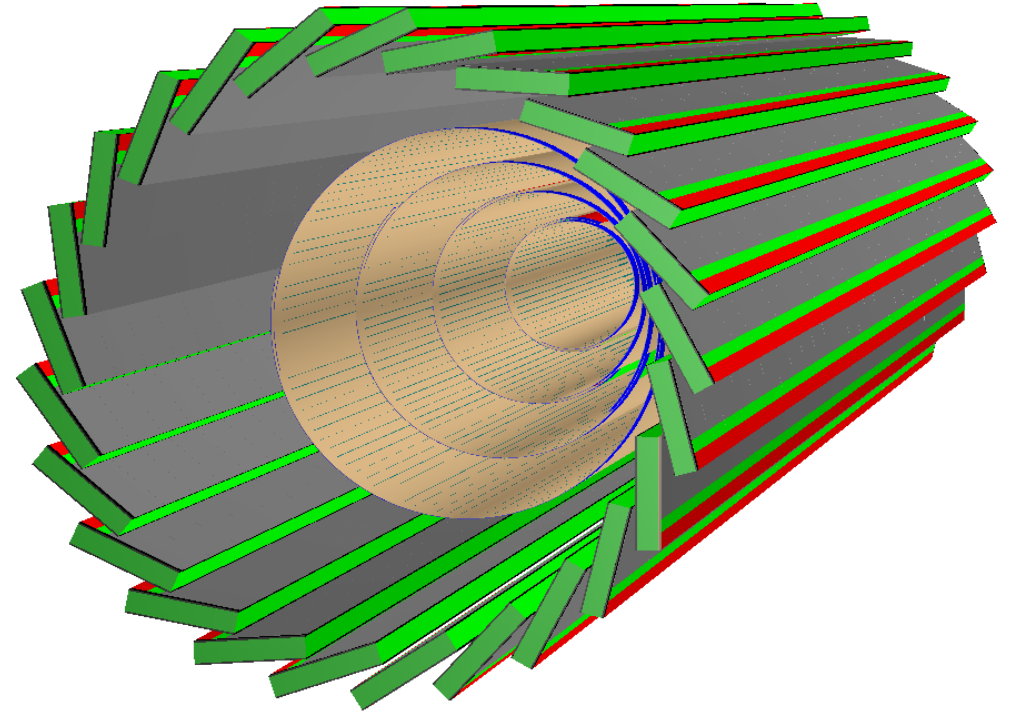
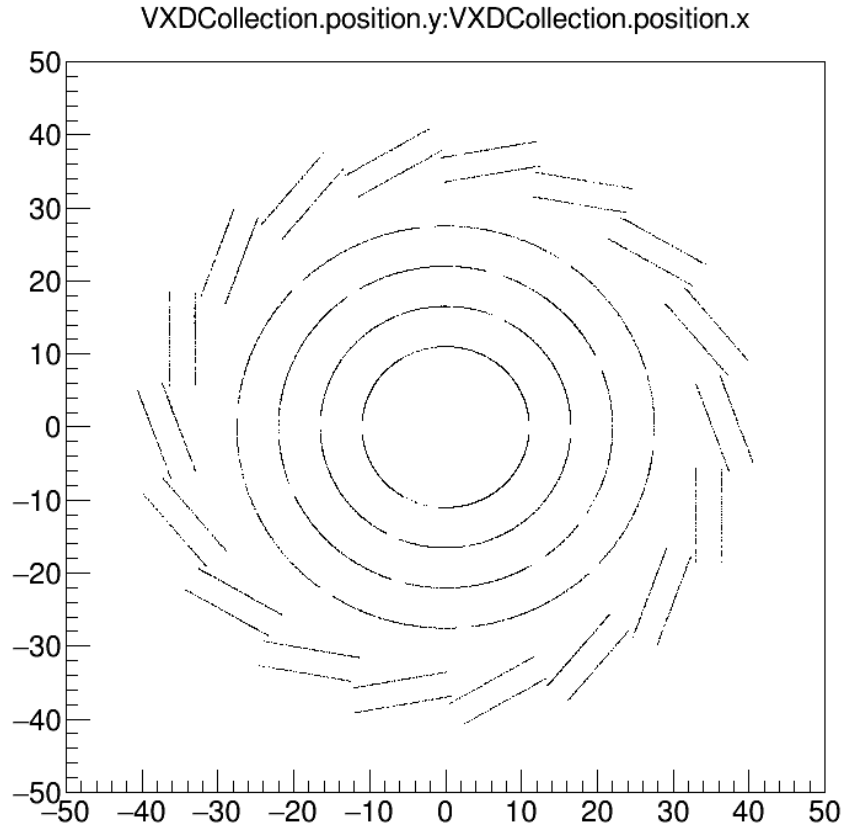
中國科學院高能物理研究所
Institute of High Energy Physics
Chinese Academy of Sciences

Software for Stitching Vertex Detector

By ChengDong

- News update

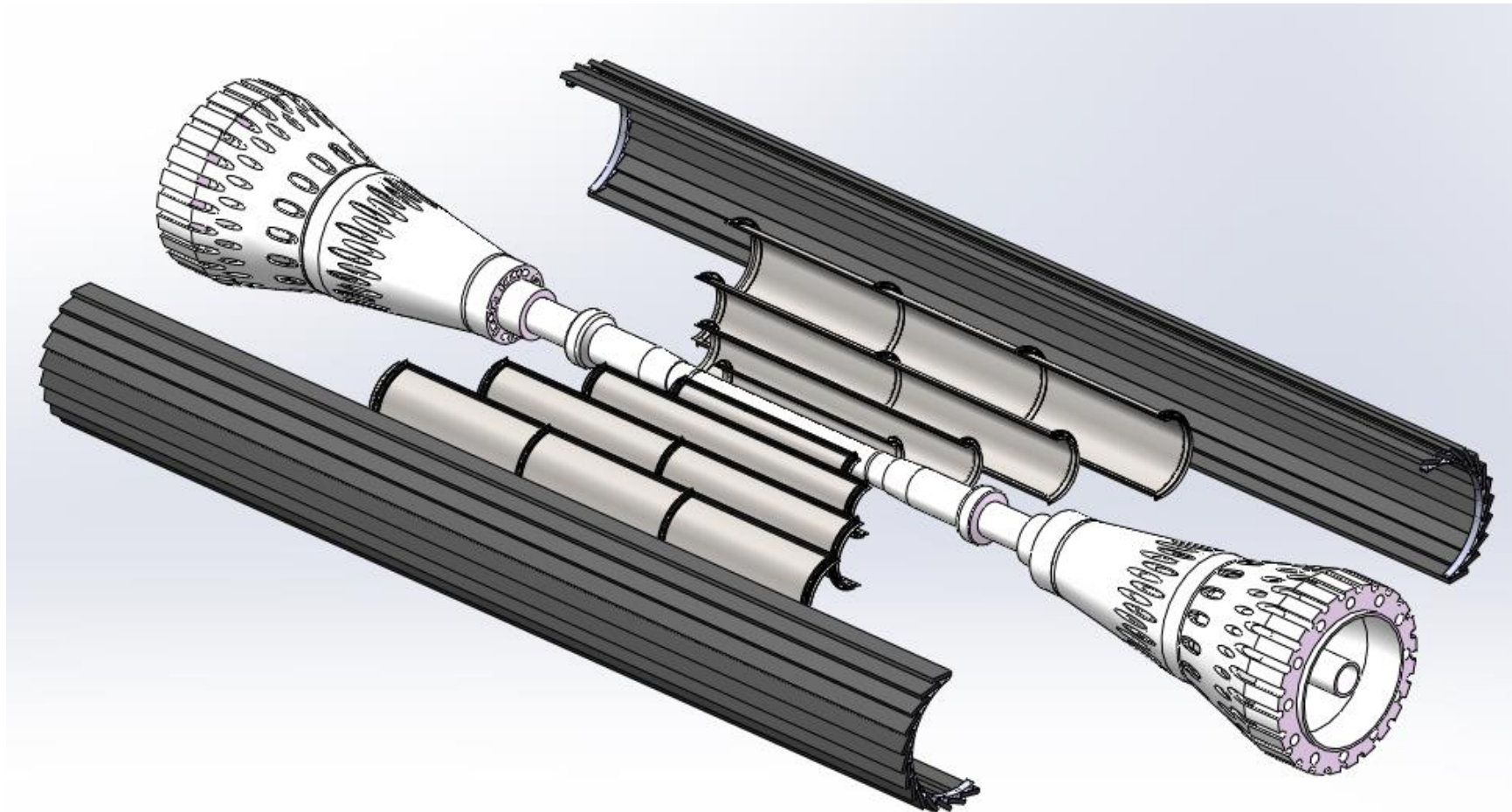
- Reconstruction on stitching + ladder layout is now ready
- To do: Performance study & layout optimization



Mechanics update

By Jinyu

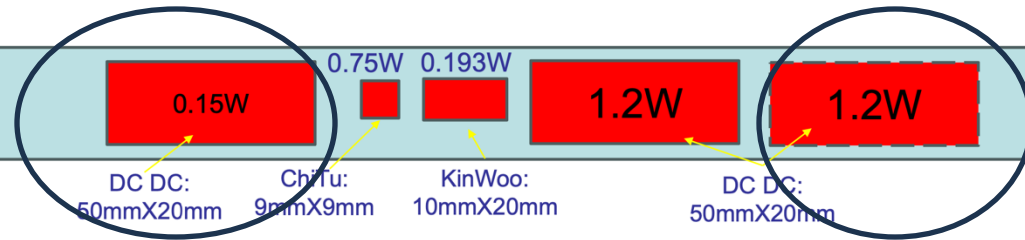
- Support structure update and installation scheme



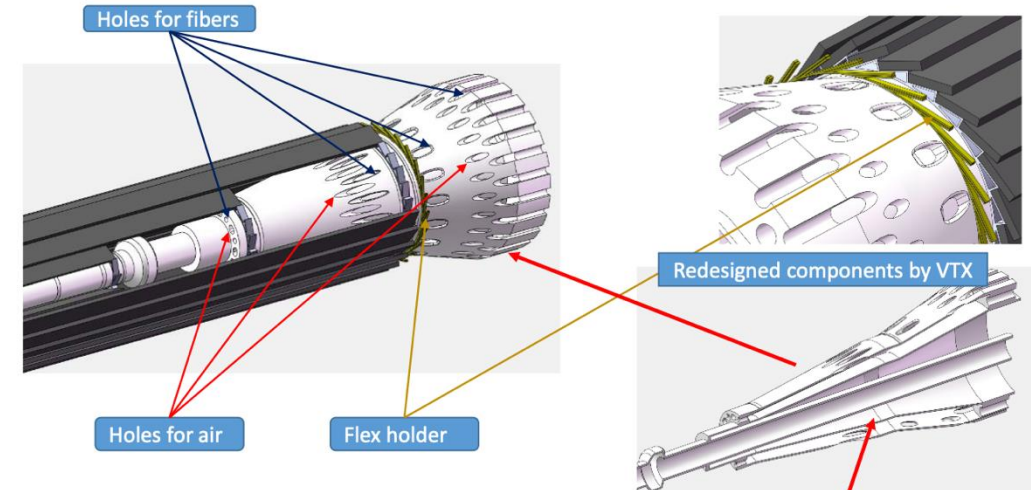
Vertex technologies: Cable and service

■ Revisit the space in MDI region for cable and service

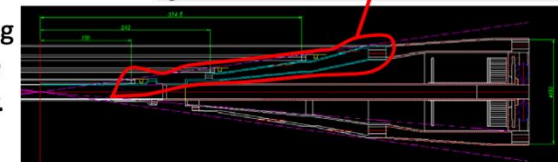
- Working to optimize the dimension on flexible PCB and components



Two DC-DC components can be removed in inner layers



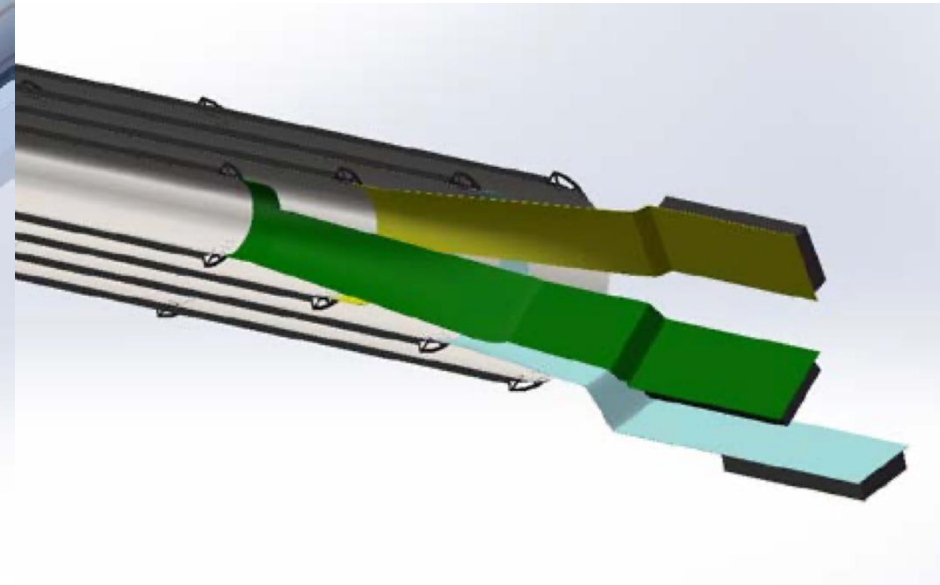
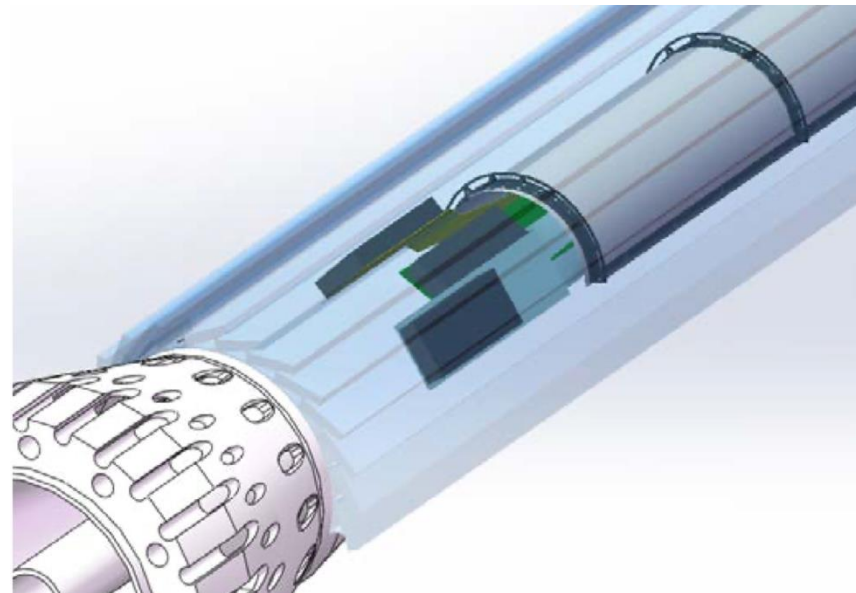
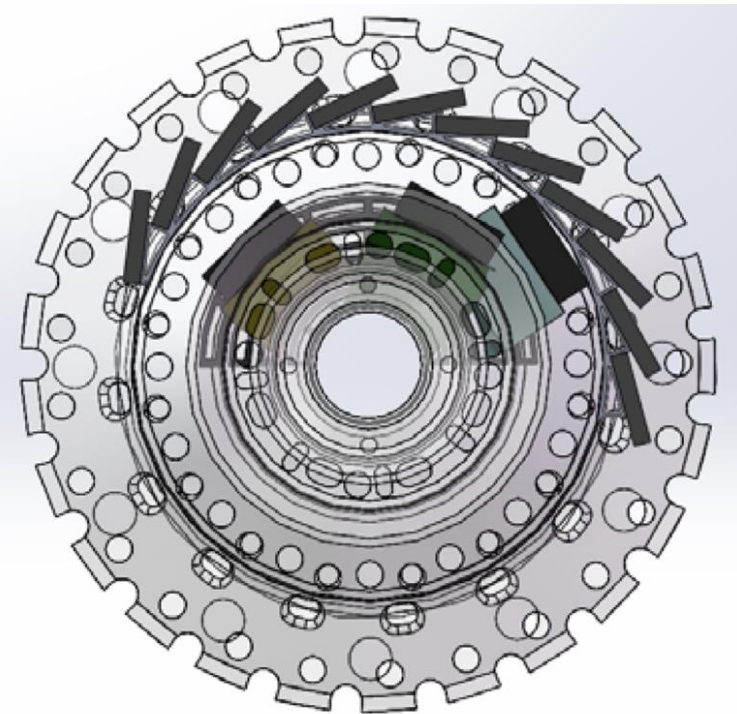
According to the current plan, assuming the flex will be switched to fiber where beyond and near the end of the ladder.



Space for service and cabling

By Jinyu

- Two Flexible PCB + DC-DC components for one layer (upper and lower part)
- still optimizing space to fit in all cabling



Summary

- Software for Stitching Vertex Detector is now ready
- In progress of optimizing PCB, service and cable space for inner layer

International collaboration

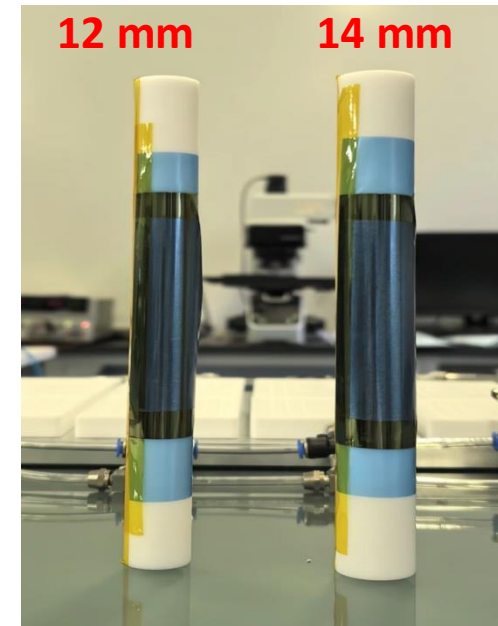
- Contacting with Jérôme Baudot, vertex group leader in IPHC/CNRS
- Jérôme Baudot is planning to join CEPC workshop 2024 in person
- Wei Wei, Ying, Yunpeng and I will join PIXEL2024 in IPHC in person
 - A few talks about the CEPC vertex accepted in PIXEL2024 (Nov 18-22)

Stitching R & D

- New thinned dummy wafers received.

- Thinned to $\sim 30\mu\text{m}$
- Expected to bent it to $\sim 11\text{mm}$ radius

By Mingyi



	Status	CEPC Final goal
Bent silicon with radius	Bent Dummy wafer radius $\sim 12\text{mm}$	Bent final wafer with radius $\sim 11\text{mm}$

Status of Software for Stitching Vertex Detector

Geometry

- TaiCHu → STITching → composite (TCH+STT)

Reconstruction

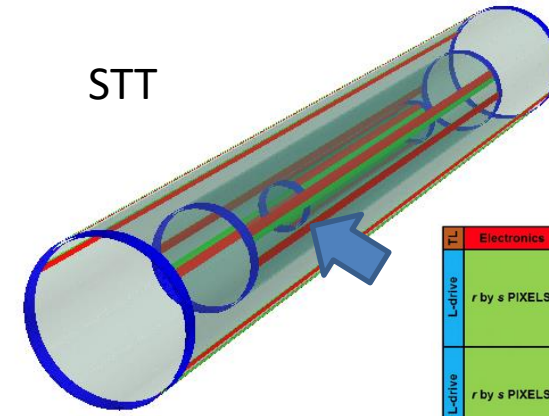
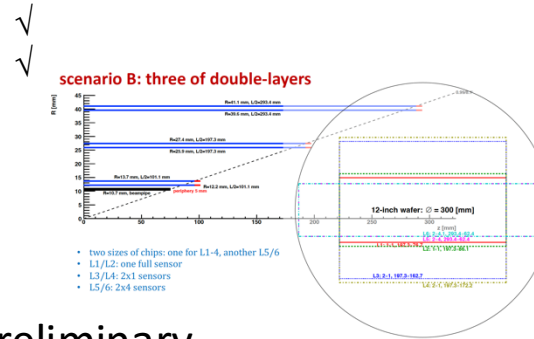
- Planar measurement → Cylinder measurement
- Processor for STT

Validation

- STT VS TCH on three of double-layers

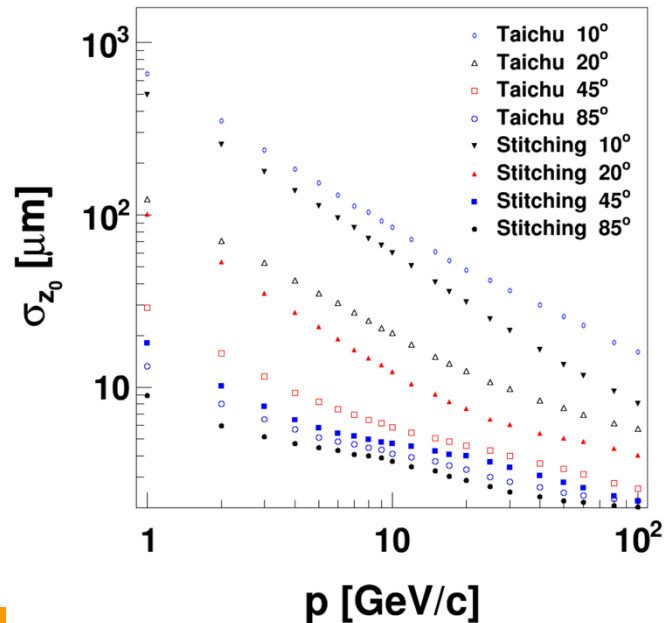
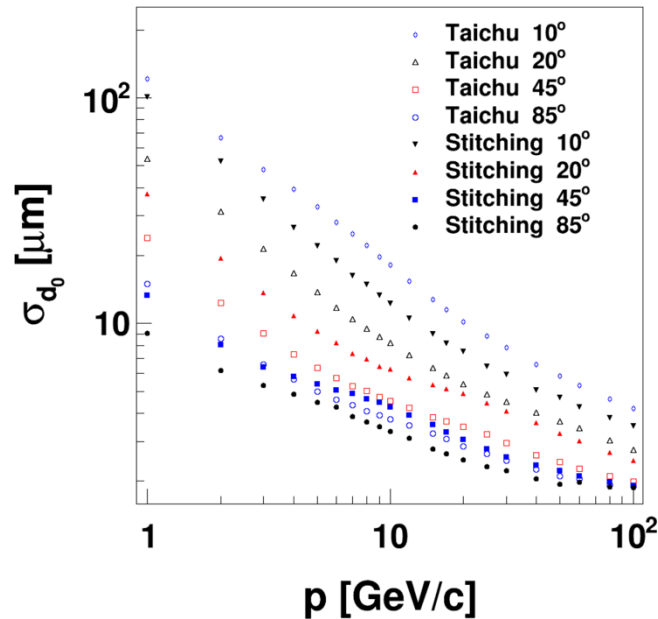
Todo

- Reconstruction on STT+TCH
- Performance & layout

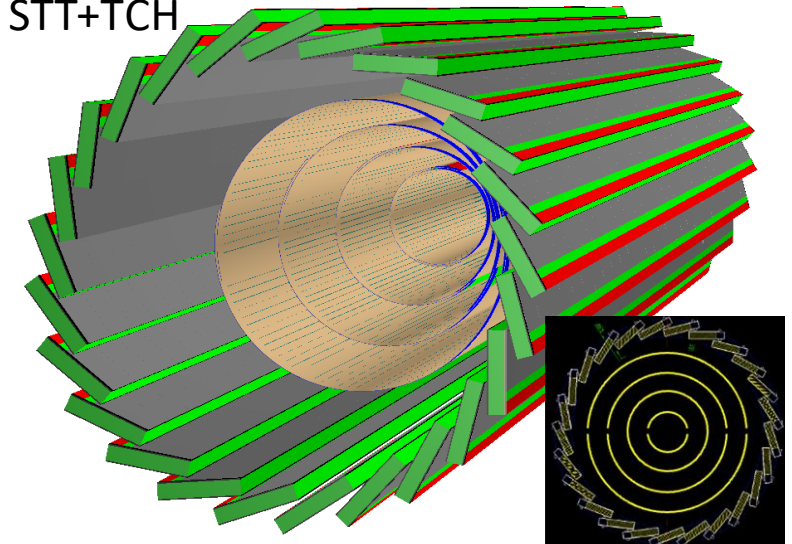


TL	Electronics	Electronics	Electronics	TR
L-drive	r by s PIXELS	r by s PIXELS	r by s PIXELS	R-drive
L-drive	r by s PIXELS	r by s PIXELS	r by s PIXELS	R-drive
BL	Readout	Readout	Readout	BR

preliminary



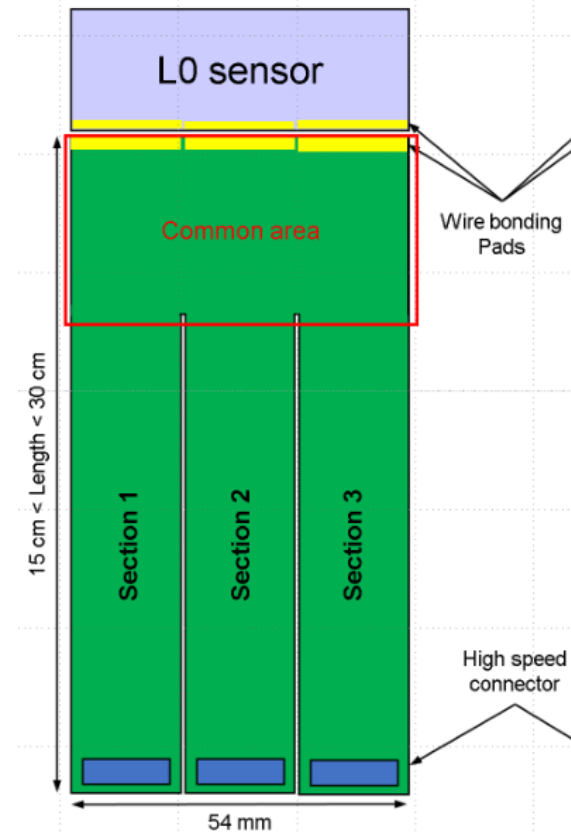
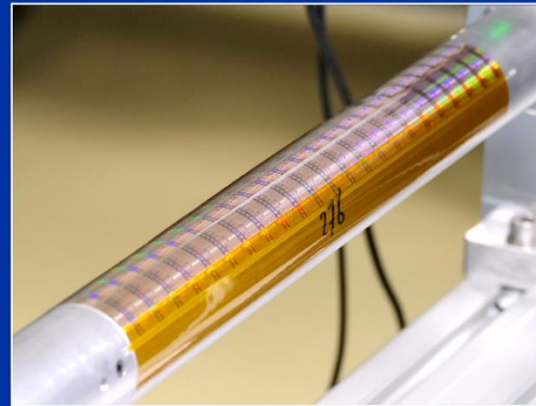
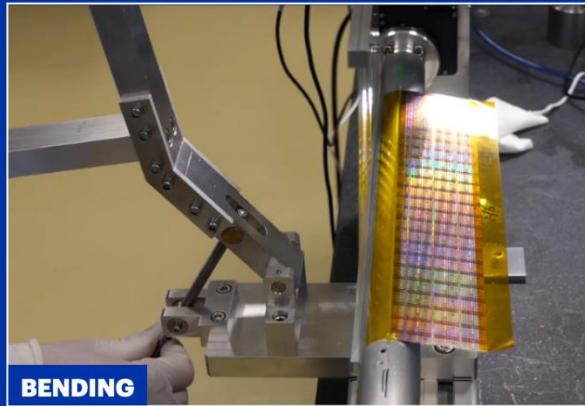
STT+TCH



Vertex technologies: Cable and service

- Refine the design for wire bonding and PCB

ITS3 bending/interconnection procedure

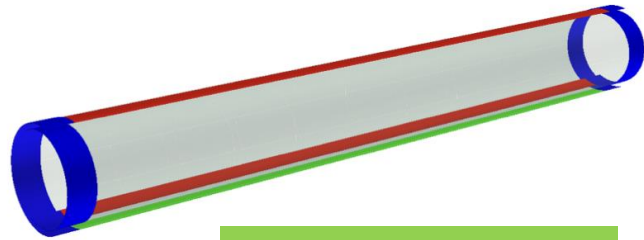


Update in CEPCSW

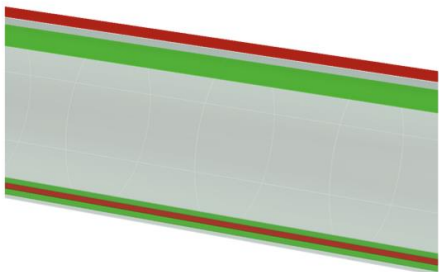
Stitching layer layout is implemented in CEPCSW

- Dead area is also considered
- Digitization is OK now, can be used for BG simulation
- Code for reconstruction is still under development

Module -> Layer

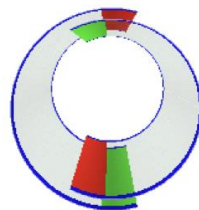


By Chengdong Fu

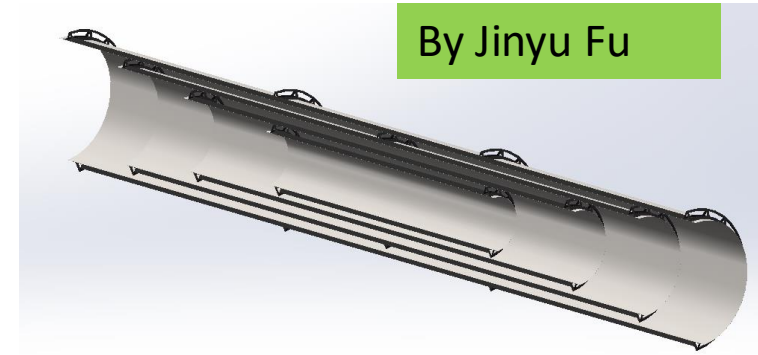


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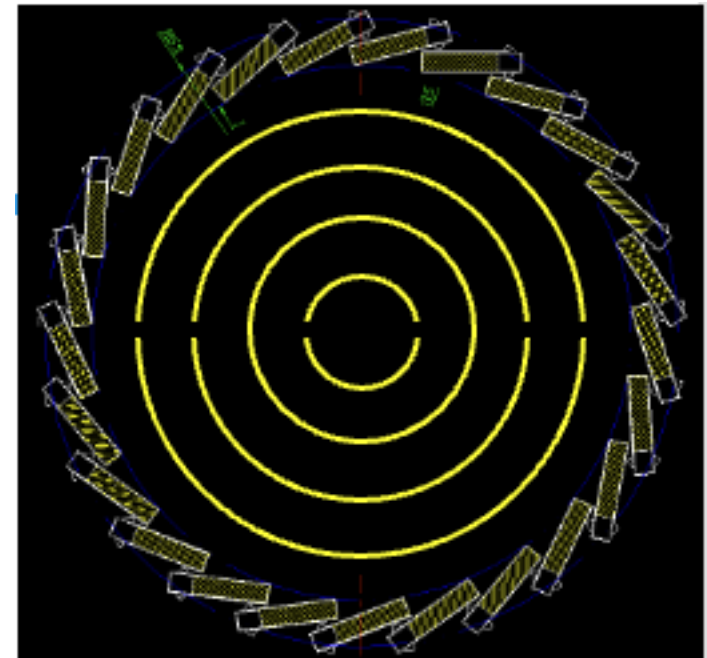
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Parameter to confirm



By Jinyu Fu



Total power

by Wei Wei

VTX-Power Link



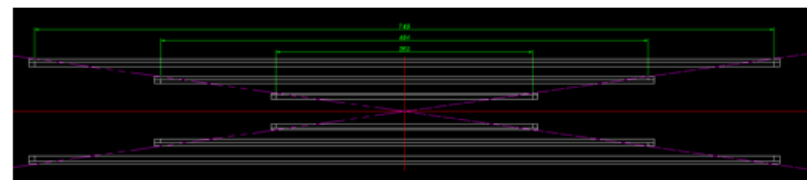
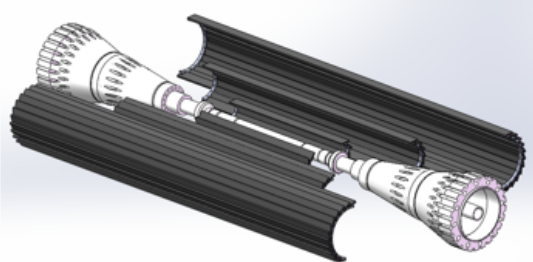
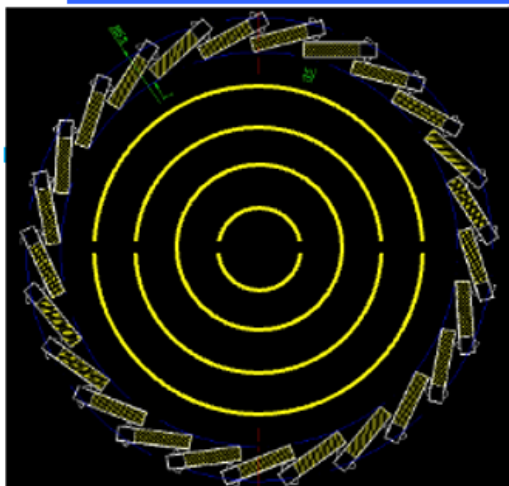
Layer	Comment	Power/chip	Chips/Row	Power/row	Rows	Chip Power of Layers	Power consumed of BaSha (15%)	Total Power/Layer
1	Stitching	200mW	8	1.6W	2*2=4	6.4W	0.96W	8.51W
2	Stitching	200mW	12	2.4W	3*2=6	14.4W	2.16W	17.71W
3	Stitching	200mW	16	3.2W	4*2=8	25.6W	3.84W	30.59W
4	Stitching	200mW	20	4W	5*2=10	40W	6W	47.15W
5	Ladder-side0	200mW	29	5.8W	25	145W	21.75W	167.9W
6	Ladder-side1	200mW	29	5.8W	25	145W	21.75W	167.9W

- 探测器前提假设一致，每芯片功耗估算为200mW ($40\text{mW}/\text{cm}^2 * 2.6\text{cm} * 1.6\text{cm}$)
- @40MHz (BX=25ns)，如按15ns，功耗将成倍增加
- 主要功耗贡献：模拟静态功耗+数据接口，不随本底数据率变化，因此不考虑按各层本底的功耗 scaling down
- 设BaSha DC-DC效率为85%，则功耗开销为15%
- 每行固定功耗：数据接口1W+数据接口开销0.15W=1.15W
- 总功耗439.8W（可按1~3层、4层各一个电源通道，5、6每层各两个电源通道@100W/ch考虑，共6个电源通道）

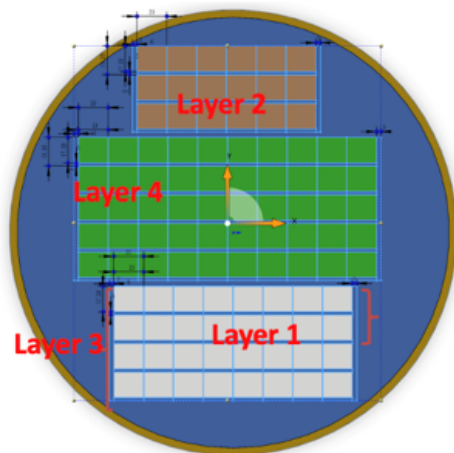
Total Data rate

by Wei Wei

VTX



- 安全因子1.5，加速器50MW，按内层2Gbps/chip为数据率基准，按higgs mode本底比例计算各层，各层芯片数量内四层以RSU为单位，外两层（double sided）以芯片为单位



Layer	Comment	Data Rate/chip	Chips/ Row	Data rate/row	Rows	Links@10Gbps
1	Stitching	2Gbps	8	16G	2*2=4	2*4=8
2	Stitching	1.3Gbps	12	15.6G	3*2=6	2*6=12
3	Stitching	0.27Gbps	16	4.3G	4*2=8	1*8=8
4	Stitching	0.25Gbps	20	5G	5*2=10	1*10=10
5	Ladder-side0	0.16Gbps	29	4.64G	25	1*25=25
6	Ladder-side1	0.16Gbps	29	4.64G	25	1*25=25